


<b>Search Notes</b> 	<b>Application/Control No.</b> 10750660	<b>Applicant(s)/Patent Under Reexamination</b> LEE, JUNG-SUK
	<b>Examiner</b> Behncke, Christine M	<b>Art Unit</b> 3661

SEARCHED			
Class	Subclass	Date	Examiner
701	51, 62, 64, 95	11/21/07	CMB
477	126, 116	11/21/07	CMB
475	119, 133	11/21/07	CMB

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search updated	11/21/07	CMB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
701	51, 62, 64	11/21/07	CMB
477	126, 116	11/21/07	CMB